

<b>Notice of References Cited</b>	Application/Control No. 10/650,668	Applicant(s)/Patent Under Reexamination TAKEDA ET AL.	
	Examiner Mark Hellner	Art Unit 3663	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,049,414 A	04-2000	Espindola et al.	359/337
	B	US-6,583,922 B2	06-2003	Srikant et al.	359/337
	C	US-			
	D	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Perlin et al, "ON Trade-off between noise and nonlinearity in WDM systems with ditributed Raman amplification", 2002, OFC 2002, pp. 178-180.
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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